

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/734,197	CHIEN ET AL.	
Examiner		Art Unit		Page 1 of 1
Khanh Duong		2822		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,190,977 b1	02-2001	Wu, Shye-Lin	438/300
	B	US-5,953,605 a	09-1999	Kodama, Noriyuki	438/231
	C	US-6,541,343 b1	04-2003	Murthy et al.	438/299
	D	US-6,214,736 b1	04-2001	Rotondaro et al.	438/705
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	KR2002080953A	11-2003	KOREA	LEE ET AL.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.